

FIG. 1 is a schematic diagram of a device 100 for measuring the thickness of a substrate 101.

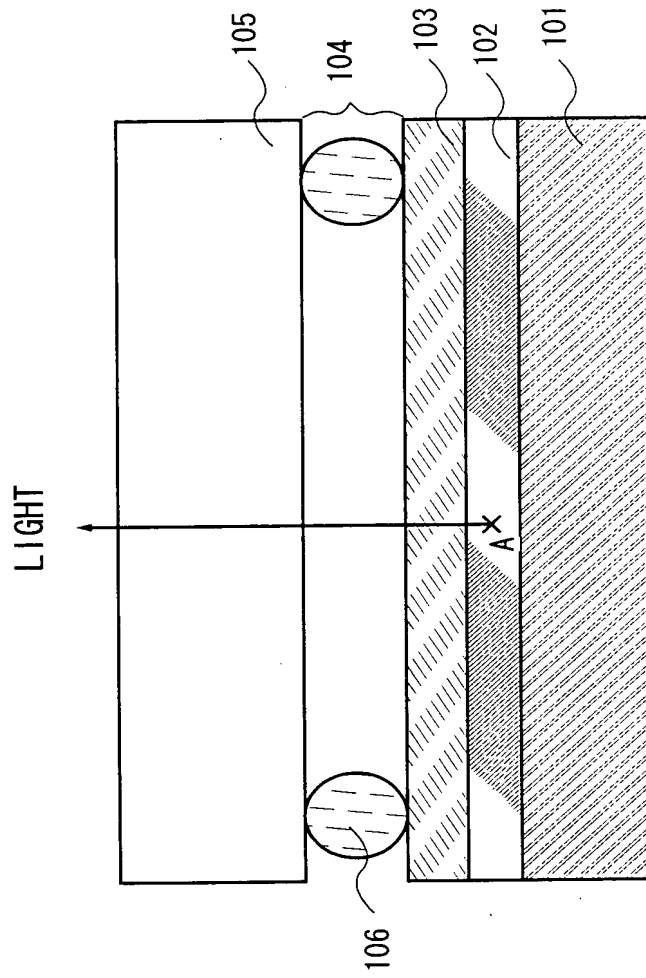


FIG. 1

$$n_1 > n_2 \quad \theta_0 = \sin^{-1}(n_2/n_1)$$

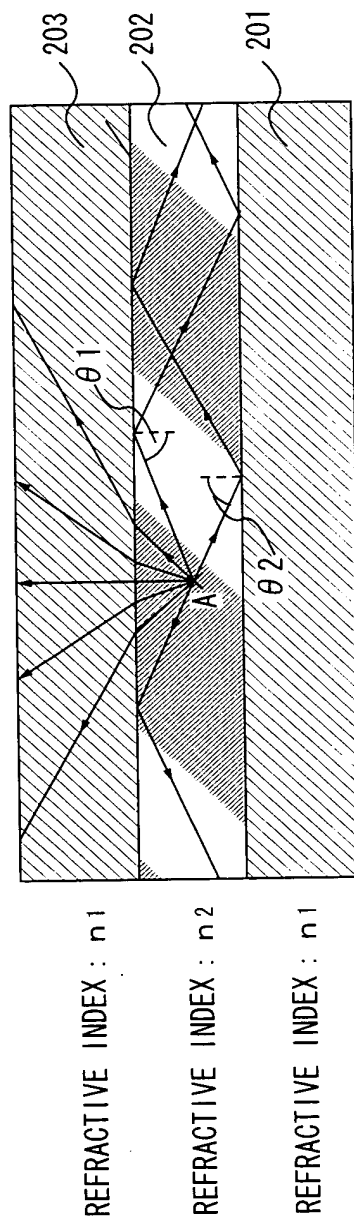


FIG. 2

FIG. 3 is a cross-sectional view of a light emitting device in accordance with an embodiment of the present invention.

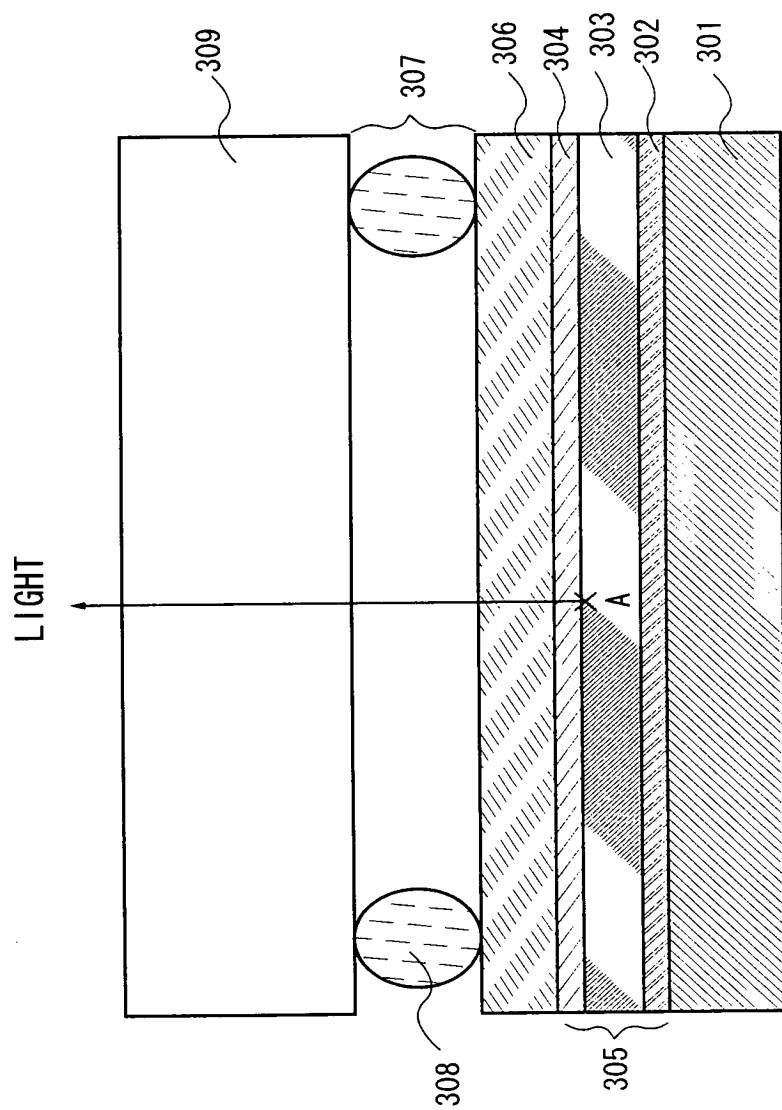


FIG. 3

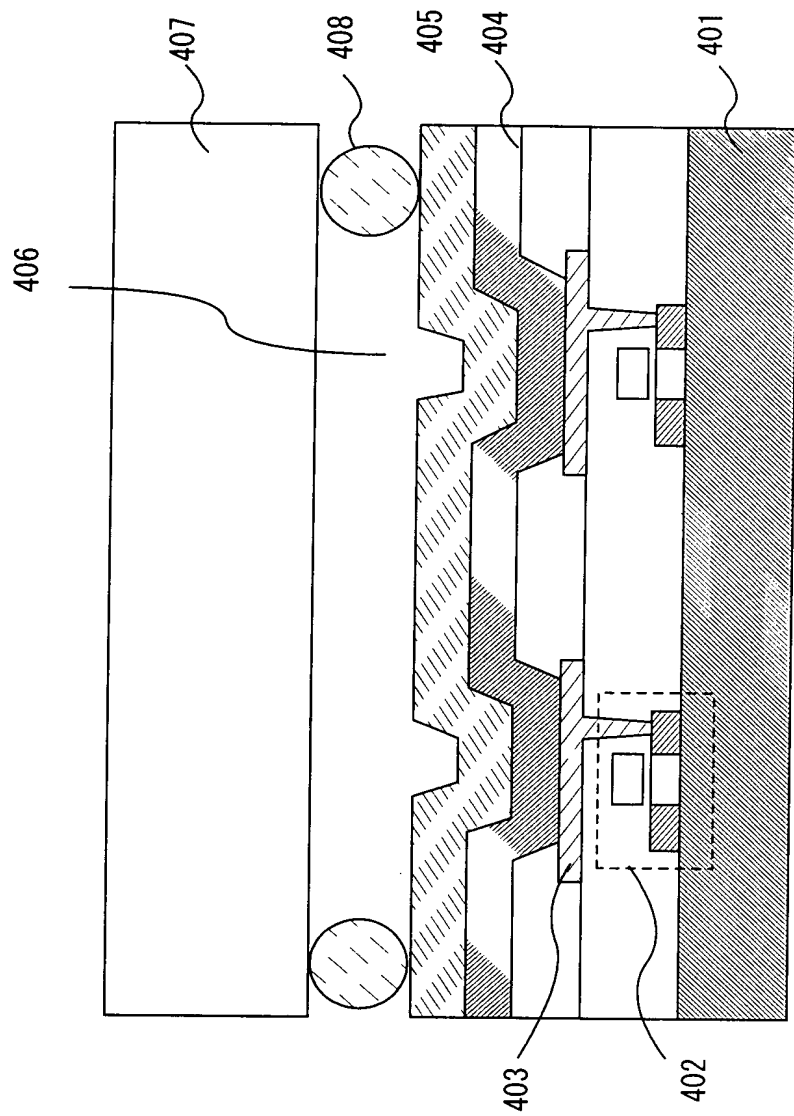


FIG. 4

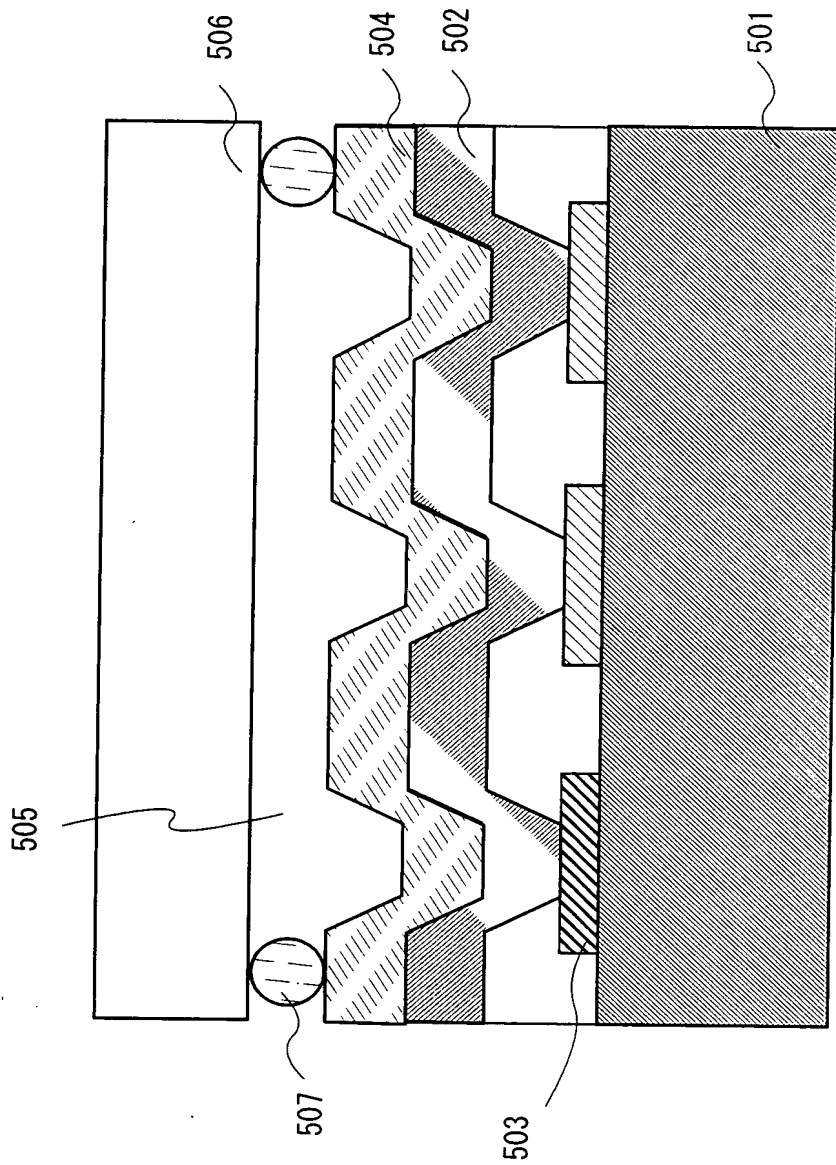


FIG. 5